

Search Notes

Application/Control No.

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Examiner

Christopher H. Yaen

Applicant(s)/Patent under
Reexamination

HIRASHIMA ET AL.

Art Unit

1642

SEARCHED

Class	Subclass	Date	Examiner
Updated			

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
514	2	4/15/2005	CY
Stic seq search of SEQ ID No: 1-3		4/14/2005	CHY

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Updated searches	4/13/2005	CHY
Palm Inventor Search	4/13/2005	CHY
Stic SEQ ID No: 3	4/14/2005	CHY